Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/837,151	BENDER ET AL.	
Examiner	Art Unit	
Brian D. Nguyen	2661	

SEARCHED			
Class	Subclass	Date	Examiner
370	328 329 331 338	11/15/05	1310
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Eat	11/15/05 5/4/06	<i>パ</i> ス